OTF TRADEMIN

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE C. Thousand

Applicant

Seiichi HAYASHI, et al.

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METHOD AND APPARATUS FOR MEASURING

THIN FILM, AND THIN FILM DEPOSITION

SYSTEM

Group Art Unit

2882

Examiner

David P. Porta

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I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to ASSISTANT COMMISSIONER FOR PATENTS, WASHINGTON, DC 20231 on September 27, 2002

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INFORMATION DISCLOSURE STATEMENT

Sir:

Submitted herewith is an Information Disclosure Citation together with a copy of reference referred to therein.

Respectfully submitted,

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